

**Search Notes**

Application/Control No.

10/820,742

Examiner

James D. Ewart

Applicant(s)/Patent under  
Reexamination

LIAO ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
455	405 406 414.1 414.2 414.3	9/11/2006	JDE
	426.1 466		
701	200 201		
	208-211		
370	395.5		
707	104.1		
709	217-219		
	230		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR